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			09/25/2007	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)	
	10/523,875	KRUEGER ET AL.	
Office Action Summary	Examiner	Art Unit	• • •
	Cuong Q. Nguyen	2811	!.
The MAILING DATE of this communication app	ears on the cover sheet with the c	orrespondence addres	ss
Period for Reply			
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication. If NO period for reply is specified above, the maximum statutory period was really received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tin rill apply and will expire SIX (6) MONTHS from cause the application to become ARANDONE	N. nely filed the mailing date of this commu	•
Status			
1) Responsive to communication(s) filed on			• •
	action is non-final.		•
3)☐ Since this application is in condition for allowar		secution as to the me	erits is
closed in accordance with the practice under E			
			:
Disposition of Claims	•		:
4) Claim(s) <u>1-31</u> is are pending in the application.	•		
4a) Of the above claim(s) <u>9-11,16,18,19 and 24</u>	is/are withdrawn from considera	ition.	. •
5) Claim(s) is/are allowed.	·		
6) Claim(s) <u>1-4,7,8,12-17,20-23 and 27-31</u> is/are	rejected.	i	
7) Claim(s) <u>5, 6</u> is/are objected to.			
8) Claim(s) are subject to restriction and/or	election requirement.		:
Application Papers	, ·		:
9) The specification is objected to by the Examine	•		
10) The drawing(s) filed on is/are: a) acce	•	Evaminer	* * *
Applicant may not request that any objection to the			
Replacement drawing sheet(s) including the correcti	-	, ,	121(d)
11) The oath or declaration is objected to by the Ex			
		,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,	: .
Priority under 35 U.S.C. § 119			
12) ☐ Acknowledgment is made of a claim for foreign	priority under 35 U.S.C. § 119(a))-(d) or (f).	
a) ☐ All b) ☐ Some * c) ☐ None of:			• • •
1 Certified copies of the priority documents	s have been received.	;	
2. Certified copies of the priority documents	s have been received in Applicati	on No	
3. Copies of the certified copies of the prior	ity documents have been receive	ed in this National Stag	ge '
application from the International Bureau			:
* See the attached detailed Office action for a list	of the certified copies not receive	d.	
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A September 1 to the second of		•)
Attachment(s)	• •		
1) Notice of References Cited (PTO-892)	4) Interview Summary	(PTO_413)	
2) Notice of Draftsperson's Patent Drawing Review (PTO-948)	Paper No(s)/Mail Da		•
3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date	5) Notice of Informal P	atent Application	:
apor rio(s)mian Date	6)		

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DETAILED ACTION

Claim Objections

1. Claim 17 is objected to because of the following informalities: The term "with" in claim 17 should be changed to "to". Appropriate correction is required.

Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless --

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- (e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 1-4, 13-14, 16, 20-22, 28, and 31 are rejected under 35 U.S.C. 102(e) as being anticipated by Bureau et al. (US 6,492,194).

Regarding claims 1, 2, Bureau et al. discloses a component comprising: a chip having a top surface and having a bottom surface that includes electrically conductive tructures; a carrier substrate having a top surface that includes connecting areas, the chip being mounted in a flip chip arrangement on the carrier substrate via electrically

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conductive connections (bumps) between the electrically conductive structures and the connecting areas; a support element (107) at the top surface of the carrier substrate, the support element surrounding the chip but not touching the chip; and a seal that borders the chip and the support element, wherein the support element supports the seal. See Fig.4a.

It is noted that the Bureau et al.'s device and claimed device are identical in structure. So, the configuration of support element and the seal in the Bureau et al.'s device is capable to reduce an affect of mechanical forces on the electrically conductive connections that result from temperature variations as claimed.

Regarding claims 3, 4, 20, 21, 22, as shown in Bureau et al.'s Fig.4a, wherein the seal comprises a plastic layer (40) and substantially covers the top surface of the chip.

Regarding claims 13, as shown in Bureau et al.'s Fig.5, a dielectric layer (80) comletely covers the top surface of the chip and the support element, the dielectric layer forming a seal to the carrier substrate only in areas that do not correspond to the support element so that the chip and the support element are in a shared space that is formed between the dielectric layer and the top surface of the carrier substrate.

Regarding claim 7, as shown in Bureau et al.'s Fig.4a, the support element comprises a shink frame that substantially encloses the chip.

Regarding claim 14, as shown in Bureau et al.'s Fig.5, the dielectric layer (80) completely covering the top surface of the chip and sealing the support element, wherein the support element comprising a hermitically tight material.

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Regarding claim 16, as shown in Bureau et al.'s Fig.4a, a layer (70) is considered as a filling compound on the dielectric layer (40).

Regarding claim 28, as shown in Bureau et al.'s Fig.4a, the carrier substrate including surface-mounted-device-capable contacts on its bottom surface.

Regarding claim 31, as shown in Bureau et al.'s Fig.4a, the device further comprising similar chips that are attacked the carrier substrate and that are similarly encapsulated.

Claims 1-2, 7, and 27-28 are rejected under 35 U.S.C. 102(b) as being anticipated by Bivona et al. (US 5,990,418).

Regarding claims 1, 2, Bivona et al. discloses a component comprising: a chip having a top surface and having a bottom surface that includes electrically conductive tructures; a carrier substrate having a top surface that includes connecting areas, the chip being mounted in a flip chip arrangement on the carrier substrate via electrically conductive connections (bumps) between the electrically conductive structures and the connecting areas; a support element (a hermitically tight material 110) at the top surface of the carrier substrate, the support element surrounding the chip but not touching the chip; and a seal (104) that borders the chip and the support element, wherein the support element supports the seal. See Bivona's Fig.1-2.

It is noted that the Bivona's device and claimed device are identical in structure. So, the configuration of support element and the seal in the Bivona's device is capable to

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reduce an affect of mechanical forces on the electrically conductive connections that result from temperature variations as claimed.

Regarding claim 7, as shown in Bivona et al.'s Fig.1, the support element comprises a shink frame that substantially encloses the chip.

Regarding claim 27, Bivona et al. teaches that the carrier substrate is formed of ceramic. See claim 11.

Regarding claim 28, as shown in Bivona et al.'s Fig.2, the carrier substrate including surface-mounted-device-capable contacts on its bottom surface.

Claims 1-2 and 28-29 are rejected under 35 U.S.C. 102(b) as being anticipated by Ando et al. (US 6,433,412).

Regarding claims 1, 2, Ando et al. discloses a component comprising: a chip having a top surface and having a bottom surface that includes electrically conductive tructures; a carrier substrate having a top surface that includes connecting areas, the chip being mounted in a flip chip arrangement on the carrier substrate via electrically conductive connections (bumps) between the electrically conductive structures and the connecting areas; a support element (12) at the top surface of the carrier substrate, the support element surrounding the chip but not touching the chip; and a seal (11) that borders the chip and the support element, wherein the support element supports the seal. See Ando et al.'s Fig.1-2.

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It is noted that the Ando et al.'s device and claimed device are identical in structure. So, the configuration of support element and the seal in the Ando et al.'s device is capable to reduce an affect of mechanical forces on the electrically conductive connections that result from temperature variations as claimed.

Regarding claim 28, as shown in Ando et al.'s Fig.2, the carrier substrate including surface-mounted-device-capable contacts on its bottom surface.

Regarding claim 29, as shown in Ando et al.'s Fig.2, the carrier substrate comprising at least two dielectric layers (each of metalizations layer being formed on a dielectric layer).

The limitation "low temrature cofired" in claim 27 is taken to be a product by process limitation, it is the patentability of the claimed product and not of recited process steps which must be established. Therefore, when the prior art discloses a product which reasonably appears to be identical with or only slightly different than the product claimed in a product-by process claim, a rejection based on sections 102 or 103 is fair. A product by process claim directed to the product per se, no matter how actually made, In re Hirao, 190 USPQ 15 at 17 (footnote 3). See In re Fessman, 180 USPQ 324,326(CCPA 1974); In re Marosi et al., 218 USPQ 289,292 (Fed. Cir. 1983); and particularly In re Thorpe, 227 USPQ 964,966 (Fed. Cir. 1985), all of which make it clear that it is the patentability of the final structure of the product "gleaned" from the process steps, which must be determined in a "product by process" claim, and not the patentability of the process. See also MPEP 2113. Moreover, an old or obvious product

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produced by a new method is not a patentable product, whether claim in "product by process" claim or not.

The limitation, "wherein the support element and the seal are configured to reduce an affect of mechanical forces on the electrically conductive connections that result from temperature variations as claimed" in claim 1 is taken to be mere statements of intended use which does not add any structure, therefore it has not been given any patentable weight. Claims directed to apparatus must be distinguished from the prior art in terms of structure rather than function. In re Danley, 120 USPQ 528, 531 (CCPA 1959). "Apparatus claims cover what a device is, not what a device does."(emphasis in original) Hewlett - Packard Co. V. Bausch & Lomb Inc., 15 USPQ2d 1525, 1528 (Fed. Cir. 1990). A claim containing a "recitation with respect to the manner in which a claimed apparatus is intended to be employed does not differentiate the claimed apparatus from a prior art apparatus" if the prior art apparatus teaches all the structural limitations of the claim. Ex parte Masham, 2 USPQ2d 1647. Claims directed to apparatus must be distinguished from the prior art in terms of structure rather than function. In re Danley,120 USPQ 528, 531 (CCPA 1959). "Apparatus claims cover what a device is, not what a device does."(emphasis in original) Hewlett - Packard Co . v. Bausch & Lomb Inc., 15 USPQ2d 1525, 1528 (Fed. Cir. 1990). In apparatus, article, and composition claims, intended use must result in a structural difference between the claimed invention and the prior art in order to patentably distinguish the claimed invention from the prior art.

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Claim Rejections - 35 USC § 103

3. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claim 12, 15, 17, 23, and 30 are rejected under 35 U.S.C. 103(a) as being unpatentable over Bureau et al.

Regarding claims 12 and 15, Bureau et al. teaches that the layer (60) is a conductive layer above the seal (40) relative to the top surface of the chip, the layer (60) being on edge areas of the support element. However, Bureau et al. but does not explicitly teach that the conductive layer is a metal layer.

It is conventional that metal is commonly used to form a conductive layer in a semiconductor device because metal has excellence electrical and thermal conductivities.

So, it would have been obvious to one of ordinary skill in the art to form the conductive layer (60) in Bureau et al.'s device by a metal layer in order to obtain a conductive layer with excellence electrical and thermal conductivity properties.

Regarding claim 17, as shown in Bureau et al.'s Fig.4a, a conductive layer (80) that forms a seal to the carrier substrate outside of an area that corresponds to the support element. Bureau et al. Does not explicitly teach that the conductive layer is formed of metal.

It is conventional and known in the art that metal is an art recognized material for forming conductive layer for the seal layer in the packaging.

So, it would have been obvious to one of ordinary skill in the art to form the conductive layer of a known material for sealing such as metal.

Regarding claim 23, the rejection of claim 23 is based on the same reasons as applied in claims 12 and 15 above.

Regarding claim 30, Bureau et al. teach that the chip is related to a surface acoustic wave filter (col.1 lines 1-25). However, Bureau et al. does not explicitly teach that at least one resonator works with the acoustic surface waves.

It would have been obvious to one of ordinary skill in the art to form the chip that including a resonator as claimed because it is conventional and known in the art that resonator is commonly formed in the chip in order to work with the acoustic surface waves.

Response to Arguments

4. Applicant's arguments filed 06-28-07 have been fully considered but they are not persuasive. Applicants argue that the element in the applied art do not intend to use for

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the support structure. In response, although the applied art do not use the element for the support reason, however the seal is formed on the element so the element can function as a support structure.

Allowable Subject Matter

5. Claims 5 and 6 are objected to as being dependent upon a rejected base claim, but would be allowable if rewritten in independent form including all of the limitations of the base claim and any intervening claims.

Conclusion

6. THIS ACTION IS MADE FINAL. Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the mailing date of this final action.

7. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Cuong Nguyen whose telephone number is (571) 272-

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1661. The examiner can normally be reached on 8:00 am to 5:30 pm. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Richard Elms can be reached on (571) 272-1869. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

8. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published

applications may be obtained from either Private PAIR or Public PAIR.

Status information for unpublished applications is available through Private PAIR only.

For more information about the PAIR system, see http://pair-direct.uspto.gov. Should

you have questions on access to the Private PAIR system, contact the Electronic

Business Center (EBC) at 866-217-9197 (toll-free).

Cuong Nguyen

Primary examiner

9/16/07